## INTEGRATED CIRCUITS



Product specification

1992 May 04

IC15 Data Handbook



HILIP

## 74F579

### **FEATURES**

- Fully synchronous operation
- Multiplexed 3-State I/O ports for bus oriented applications
- Built in cascading carry capability
- U/D pin to control direction of counting
- Separate pins for Master reset and Synchronous operation
- Center power pins to reduce effects of package inductance
- Count frequency 115MHz Typ
- Supply current 100mA Typ
- See 74F269 for 24-pin separate I/O port version
- See 74F779 for 16-pin version

#### DESCRIPTION

The 74F579 is a fully synchronous 8-stage Up/Down Counter with multiplexed 3-State I/O ports for bus-oriented applications. It features a preset capability for programmable operation, carry look-ahead for easy cascading and a U/D input to control the direction of counting. All state changes, except for the case of asynchronous reset, are initiated by the rising edge of the clock. TC output is not recommended for use as a clock or asynchronous reset due to the possibility of decoding spikes.

### **PIN CONFIGURATION**



### **ORDERING INFORMATION**

TYPE	TYPICAL f <sub>MAX</sub>	TYPICAL SUPPLY CURRENT (TOTAL)
74F579	115MHz	100mA

### **ORDERING INFORMATION**

DESCRIPTION	$\begin{array}{l} \text{COMMERCIAL RANGE} \\ \text{V}_{CC} = 5\text{V} \pm 10\%, \\ \text{T}_{amb} = 0^{\circ}\text{C to } + 70^{\circ}\text{C} \end{array}$	PKG DWG #
20-Pin Plastic DIP	N74F579N	SOT146-1
20-Pin Plastic SOL	N74F579D	SOT163-1

### INPUT AND OUTPUT LOADING AND FAN-OUT TABLE

PINS	DESCRIPTION	74F(U.L.) HIGH/LOW	LOAD VALUE HIGH/LOW
1/0	Data Inputs	3.5/1.0	70µA/0.6mA
I/O <sub>n</sub>	Data Outputs	150/40	3.0mA/24mA
PE	Parallel Enable input (active Low)	1.0/1.0	20µA/0.6mA
U/D	Up/Down count control input	1.0/1.0	20µA/0.6mA
MR	Master Reset input (active Low)	1.0/1.0	20µA/0.6mA
SR	Synchronous Reset input (active Low)	1.0/1.0	20µA/0.6mA
CEP	Count Enable Parallel input (active Low)	1.0/1.0	20µA/0.6mA
CET	Count Enable Trickle input (active Low)	1.0/1.0	20µA/0.6mA
CS	Chip Select input (active Low)	1.0/1.0	20µA/0.6mA
ŌĒ	Output Enable input (active Low)	1.0/1.0	20µA/0.6mA
СР	Clock input (active Rising Edge)	1.0/1.0	20µA/0.6mA
TC	Terminal Count Output (active Low)	50/33	1.0mA/20mA

NOTE: One (1.0) FAST Unit Load (U.L.) is defined as: 20µA in the High state and 0.6mA in the Low state.

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LOGIC SYMBOL



LOGIC SYMBOL (IEEE/IEC)



### **FUNCTION TABLE**

				INPUTS					OPERATING MODE
MR	SR	CS	PE	CEP	CET	U/D	OE	СР	
Х	Х	н	Х	Х	Х	Х	Х	Х	I/O0 to I/O7 in high impedance (PE disabled)
Х	х	L	н	х	x	х	Н	X	I/O0 to I/O7 in high impedance
Х	Х	L	Н	Х	Х	Х	L	Х	Flip-flop output appears on I/On lines
L	Х	Х	Х	Х	Х	Х	Х	Х	Asynchronous reset for all flip-flops
Н	L	Х	Х	Х	Х	Х	Х	↑	Synchronous reset for all flip-flops
Н	н	L	L	Х	Х	Х	Х	↑	Parallel load all flip-flops
Н	н	(not	LL)	н	Х	Х	Х	↑	Hold
Н	н	(not	LL)	Х	н	Х	Х	↑	Hold (TC held High)
Н	н	(not	LL)	L	L	Н	Х	↑	Count up
Н	Н	(not	LL)	L	L	L	Х	↑	Count down

L Low voltage level =

= Don't care

X ↑ Low-to-High clock transition =

CS and PE should never be Low voltage level at the same time. (not LL) =





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### **ABSOLUTE MAXIMUM RATINGS**

(Operation beyond the limits set forth in this table may impair the useful life of the device.

Unless otherwise noted these limits are over the operating free-air temperature range.)

SYMBOL	PARAMETER		RATING	UNIT
V <sub>CC</sub>	Supply voltage		-0.5 to +7.0	V
V <sub>IN</sub>	Input voltage		-0.5 to +7.0	V
I <sub>IN</sub>	Input current		-30 to +5	mA
Vo	Voltage applied to output in High output state		–0.5 to +V <sub>CC</sub>	V
	Current applied to output in Low output state	TC	40	mA
I <sub>O</sub>	Current applied to output in Low output state	I/O0	48	mA
T <sub>amb</sub>	Operating free-air temperature range	0 to +70	°C	
T <sub>stg</sub>	Storage temperature		-65 to +150	°C

### **RECOMMENDED OPERATING CONDITIONS**

SYMBOL	PARAMETER				UNIT	
			MIN	NOM	MAX	
V <sub>CC</sub>	Supply voltage		4.5	5.0	5.5	V
V <sub>IH</sub>	High-level input voltage		2.0			V
V <sub>IL</sub>	Low-level input voltage				0.8	V
I <sub>IK</sub>	Input clamp current				-18	mA
		TC			-1	mA
юн	High-level output current	I/O <sub>n</sub>			-3	mA
					20	mA
I <sub>OL</sub>	Low-level output current				24	mA
T <sub>amb</sub>	Operating free-air temperature range					

### DC ELECTRICAL CHARACTERISTICS

(Over recommended operating free-air temperature range unless otherwise noted.)

			тгот	CONDITIONS <sup>1</sup>			LIMITS		
SYMBOL	PARAMETER		IEST	MIN	TYP <sup>2</sup>	MAX	UNIT		
		TC	$V_{CC} = MIN,$	L = 1mA	±10%V <sub>CC</sub>	2.5			V
Maria	High-level output voltage	I/On	V <sub>IL</sub> = MAX, V <sub>IH</sub> = MIN	$I_{OH} = -1 mA$	$\pm 5\% V_{CC}$	2.7	3.4		V
V <sub>OH</sub>	r ligh-level output voltage		(V <sub>IL</sub> = 0.0V, V <sub>IH</sub> = 4.5V	1 2004	±10%V <sub>CC</sub>	2.4	3.3		V
		1/On	for MR, CP inputs)	I <sub>OH</sub> = -3mA	$\pm 5\% V_{CC}$	2.7	3.3		V
M			$V_{CC} = MIN,$		±10%V <sub>CC</sub>		0.35	0.50	V
V <sub>OL</sub>	Low-level output voltage		$V_{IL} = MAX,$ $V_{IH} = MIN$	I <sub>OL</sub> = MAX,	±5%V <sub>CC</sub>		0.35	0.50	V
V <sub>IK</sub>	Input clamp voltage		V <sub>CC</sub> :		-0.73	-1.2	V		
	Input current	I/O <sub>n</sub>	V <sub>CC</sub> = I			1	mA		
11	at maximum input voltage	others	V <sub>CC</sub> = I			100	μΑ		
I <sub>IH</sub>	High-level input current	except	V <sub>CC</sub> = I			20	μΑ		
IIL	Low-level input current	I/On	V <sub>CC</sub> = I	$V_{CC} = MAX, V_I = 0.5V$				-0.6	mA
I <sub>OZH</sub> + I <sub>IH</sub>	Off-state output current High-level voltage applied	1/0	V <sub>CC</sub> = N	$V_{CC} = MAX, V_O = 2.7V$				70	μA
I <sub>OZL</sub> + I <sub>IL</sub>	Off-state output current Low-level voltage applied	I/O <sub>n</sub>	V <sub>CC</sub> = N	$V_{CC} = MAX, V_O = 0.5V$				-600	μA
I <sub>OS</sub>	Short-circuit output current <sup>3</sup>		V <sub>CC</sub> = MAX			-60		-150	mA
							95	135	mA
I <sub>CC</sub>	Supply current (total)	I <sub>CCL</sub>	V <sub>CC</sub> = MAX				105	145	mA
		I <sub>CCZ</sub>					105	150	mA

#### NOTES:

1. For conditions shown as MIN or MAX, use the appropriate value specified under Recommended Operating Conditions for the applicable

type.
All typical values are at V<sub>CC</sub> = 5V, T<sub>amb</sub> = 25°C.
Not more than one output should be shorted at a time. For testing I<sub>OS</sub>, the use of high-speed test apparatus and/or sample-and-hold techniques are preferable in order to minimize internal heating and more accurately reflect operational values. Otherwise, prolonged shorting of a High output may raise the chip temperature well above normal and thereby cause invalid readings in other parameter tests. In any converse of parameter tests. Les tests should be performed last.

## AC ELECTRICAL CHARACTERISTICS

					LIMITS			
SYMBOL	PARAMETER	TEST CONDITIONS	\	a <sub>mb</sub> = +25° / <sub>CC</sub> = +5.0V 50pF, R <sub>L</sub> =		T <sub>amb</sub> = 0°0 V <sub>CC</sub> = +5. C <sub>L</sub> = 50pF,	UNIT	
			MIN	TYP	MAX	MIN	MAX	
f <sub>MAX</sub>	Maximum clock frequency	Waveform 1	100	115		80		MHz
t <sub>PLH</sub>	Propagation delay	Waveform 1	5.0	7.5	10.5	4.5	11.5	ns
t <sub>PHL</sub>	CP to I/O <sub>n</sub>		5.0	7.5	10.5	5.0	11.5	ns
t <sub>PLH</sub>	Propagation delay	Waveform 1	5.5	7.5	10.0	5.0	11.0	ns
t <sub>PHL</sub>	CP to TC		5.5	7.5	10.0	5.0	11.0	ns
t <sub>PLH</sub>	Propagation delay	Waveform 4	3.5	5.5	8.0	3.5	9.0	ns
t <sub>PHL</sub>	U/D to TC		4.5	6.5	8.0	4.5	9.0	ns
t <sub>PLH</sub>	Propagation delay	Waveform 3	3.5	5.5	7.0	3.5	8.5	ns
t <sub>PHL</sub>	CET to TC		3.5	6.0	8.0	3.5	8.5	ns
t <sub>PHL</sub>	Propagation delay MR to I/O <sub>n</sub>	Waveform 2	5.0	7.0	9.0	5.0	10.0	ns
t <sub>PLH</sub>	Propagation delay	Waveform 4	4.0	6.5	9.0	4.0	10.5	ns
t <sub>PHL</sub>	MR to TC		6.0	8.0	10.5	6.0	12.5	ns
t <sub>PZH</sub>	Output Enable time $\overline{CS}$ to I/O <sub>n</sub>	Waveform 6	4.0	5.0	8.5	3.5	10.0	ns
t <sub>PZL</sub>		Waveform 7	5.5	7.0	10.5	5.0	11.5	ns
t <sub>PHZ</sub>	Output Disable time $\overline{CS}$ to $I/O_n$	Waveform 6	3.0	5.0	7.5	3.0	9.0	ns
t <sub>PLZ</sub>		Waveform 7	5.0	7.5	9.5	4.5	11.0	ns
t <sub>PZH</sub>	Output Enable time $\overline{PE}$ to $I/O_n$	Waveform 6	3.0	4.5	8.0	3.0	9.0	ns
t <sub>PZL</sub>		Waveform 7	5.0	6.5	10.0	4.5	11.0	ns
t <sub>PHZ</sub>	Output Disable time $\overline{PE}$ to $I/O_n$	Waveform 6	3.0	4.0	7.5	3.0	9.0	ns
t <sub>PLZ</sub>		Waveform 7	2.5	4.0	7.5	2.0	8.5	ns
t <sub>PZH</sub>	Output Disable time $\overline{OE}$ to I/O <sub>n</sub>	Waveform 6	2.5	4.0	7.0	2.5	8.5	ns
t <sub>PZL</sub>		Waveform 7	4.5	5.5	9.0	4.0	10.5	ns
t <sub>PHZ</sub>	Output Enable time	Waveform 6	1.0	2.5	4.0	1.0	5.5	ns
t <sub>PLZ</sub>	OE to I/O <sub>n</sub>	Waveform 7	2.0	4.0	7.0	2.0	8.0	ns

## AC SETUP REQUIREMENTS

					LIMITS			
SYMBOL	PARAMETER	TEST CONDITIONS	\	a <sub>mb</sub> = +25° / <sub>CC</sub> = +5.0V 50pF, R <sub>L</sub> =		$ \begin{array}{ c c } T_{amb} = 0^{\circ} 0 \\ V_{CC} = +5 \\ C_{L} = 50 \text{pF}, \end{array} $	UNIT	
			MIN	TYP	MAX	MIN	MAX	
t <sub>s</sub> (H) t <sub>s</sub> (L)	Setup time, High or Low I/O <sub>n</sub> to CP	Waveform 5	3.0 3.0			4.0 4.0		ns ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time, High or Low I/O <sub>n</sub> to CP	Waveform 5	0 0			0 0		ns ns
t <sub>s</sub> (H) t <sub>s</sub> (L)	Setup time, High or Low $U/\overline{D}$ to CP	Waveform 5	8.0 8.0			9.0 9.0		ns ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time, High or Low U/D to CP	Waveform 5	0 0			0 0		ns ns
t <sub>s</sub> (H) t <sub>s</sub> (L)	Setup time, High or Low PE, SR or CS to CP	Waveform 5	9.5 9.5			10.0 10.0		ns ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time, High or Low PE, SR or CS to CP	Waveform 5	0 0			0 0		ns ns
t <sub>s</sub> (H) t <sub>s</sub> (L)	Setup time, High or Low CEP or CET to CP	Waveform 5	5.0 9.0			5.5 10.5		ns ns
t <sub>h</sub> (H) t <sub>h</sub> (L)	Hold time, High or Low CEP or CET to CP	Waveform 5	0 0			0 0		ns ns
t <sub>w</sub> (H) t <sub>w</sub> (L)	CP Pulse width, High or Low	Waveform 1	4.5 4.5			4.5 4.5		ns ns
t <sub>w</sub> (L)	MR Pulse width, Low	Waveform 2	3.0			3.0		ns
t <sub>rec</sub>	Recovery time, MR to CP	Waveform 2	4.0			4.5		ns

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#### AC WAVEFORMS

CP

I/On

TC

NOTE: For all waveforms  $V_M = 1.5V$ .

t<sub>W</sub>(H)

V٨

t<sub>PLH</sub>

t<sub>PHL</sub>

1/f<sub>MAX</sub>

The shaded areas indicate when the input is permitted to change for predictable output performance.

VM

t<sub>PHI</sub>

t<sub>PLH</sub>

Vм



t<sub>W</sub>(L)



Waveform 3. Propagation Delay, CET Input to Terminal Count Output



Waveform 5. Setup and Hold Times



Waveform 7. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level



Waveform 2. Master Reset Pulse Width, Master Reset to Output Delay and Master Reset to Clock Recovery Time



Waveform 4. Propagation Delay, U/D and MR Inputs to Terminal Count Output



Waveform 6. 3-State Output Enable Time to High Level and Output Disable Time from High Level

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### **TEST CIRCUIT AND WAVEFORMS**







#### DIMENSIONS (inch dimensions are derived from the original mm dimensions)

UNIT	A max.	A <sub>1</sub> min.	A <sub>2</sub> max.	b	b <sub>1</sub>	с	D <sup>(1)</sup>	E <sup>(1)</sup>	e	e <sub>1</sub>	L	M <sub>E</sub>	M <sub>H</sub>	w	Z <sup>(1)</sup> max.
mm	4.2	0.51	3.2	1.73 1.30	0.53 0.38	0.36 0.23	26.92 26.54	6.40 6.22	2.54	7.62	3.60 3.05	8.25 7.80	10.0 8.3	0.254	2.0
inches	0.17	0.020	0.13	0.068 0.051	0.021 0.015	0.014 0.009	1.060 1.045	0.25 0.24	0.10	0.30	0.14 0.12	0.32 0.31	0.39 0.33	0.01	0.078

#### Note

1. Plastic or metal protrusions of 0.25 mm maximum per side are not included.

OUTLINE		REFER	RENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT146-1			SC603		<del>-92-11-17-</del> 95-05-24

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# SOT146-1



### Product specification

## 8-bit bidirectional binary counter (3-State)

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NOTES

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#### Data sheet status

Data sheet status	Product status	Definition <sup>[1]</sup>
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
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